9. A compound as claimed in claim 2 in a crystalline form.

10. A crystalline form as claimed in claim 9, characterised by an X-ray powder diffraction pattern, measured using a wavelength of X-rays 1.5418 Å, with at least one peak at 2-Theta (in degrees) selected from 8.5, 9.7, 10.6, 17.1, 19.9, and 21.2.

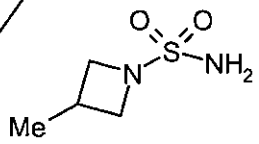
11. A crystalline form as claimed in claim 9, characterised by an X-ray powder diffraction pattern, measured using a wavelength of X-rays 1.5418 Å, with at least two or more peaks at 2-Theta (in degrees) selected from 8.5, 9.7, 10.6, 17.1, 19.9, and 21.2.

12. A crystalline form as claimed in claim 9, characterised by an X-ray powder diffraction pattern, measured using a wavelength of X-rays 1.5418 Å, with at least three peaks at 2-Theta (in degrees) selected from 8.5, 9.7, 10.6, 17.1, 19.9, and 21.2.

13. A crystalline form as claimed in claim 9, characterised by an X-ray powder diffraction pattern, measured using a wavelength of X-rays 1.5418 Å, with peaks at 2-Theta (in degrees) of 8.5, 9.7, 10.6, 17.1, 19.9, and 21.2.

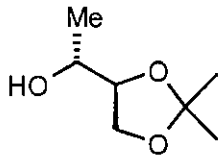
14. A crystalline form as claimed in claim 9, characterised in that said form has an X-ray powder diffraction pattern, measured using a wavelength of X-rays 1.5418 Å, substantially as shown in Figure 1.

15. A compound which is (a) an azetidine sulfonamide of formula (VIII), or (b) a salt thereof:

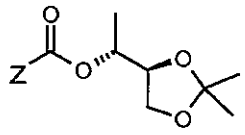


(VIII)

16. A process for preparing a compound of the formula (VI):



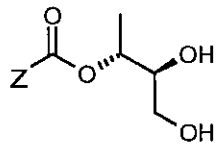
from a compound of the formula (XII):



(XII)

wherein Z is selected from 3,4,5-tri-C_{1-4}alkyoxyphenyl , 4-phenylphenyl,4-C_{1-4}alkyoxyphenyl, 2-nitrophenyl, 4-nitrophenyl and 3,5-dinitrophenyl.

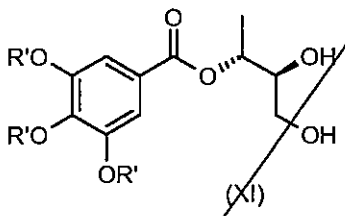
17. A process according to claim 16, wherein the compound of formula (XII) is prepared from a compound of formula (XI):



(XI)

wherein Z is as defined in claim 16.

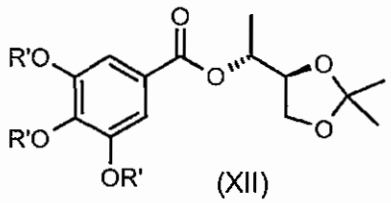
18. A compound of the formula (XI') or a salt thereof:



(XI)

wherein R' is C_{1-4}alkyl.

19. A compound of the formula (XII') or a salt thereof:



(XII)

wherein R' is C_{1-4}alkyl.

9. A compound as claimed in claim 2 in a crystalline form.

10. A crystalline form as claimed in claim 9, characterised by an X-ray powder diffraction pattern, measured using a wavelength of X-rays 1.5418 Å, with at least one peak at 2-Theta (in degrees) selected from 8.5, 9.7, 10.6, 17.1, 19.9, and 21.2.

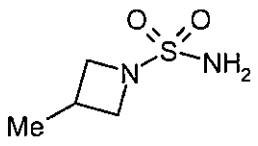
11. A crystalline form as claimed in claim 9, characterised by an X-ray powder diffraction pattern, measured using a wavelength of X-rays 1.5418 Å, with at least two or more peaks at 2-Theta (in degrees) selected from 8.5, 9.7, 10.6, 17.1, 19.9, and 21.2.

12. A crystalline form as claimed in claim 9, characterised by an X-ray powder diffraction pattern, measured using a wavelength of X-rays 1.5418 Å, with at least three peaks at 2-Theta (in degrees) selected from 8.5, 9.7, 10.6, 17.1, 19.9, and 21.2.

13. A crystalline form as claimed in claim 9, characterised by an X-ray powder diffraction pattern, measured using a wavelength of X-rays 1.5418 Å, with peaks at 2-Theta (in degrees) of 8.5, 9.7, 10.6, 17.1, 19.9, and 21.2.

14. A crystalline form as claimed in claim 9, characterised in that said form has an X-ray powder diffraction pattern, measured using a wavelength of X-rays 1.5418 Å, substantially as shown in Figure 1.

15. A compound which is (a) an azctidine sulfonamide of formula (VIII), or (b) a salt thereof:



(VIII)